EAST - [232.wsp:1]

File  View  Edit  Tools  Window  Help

Drafts
    BRS:
Pending
Active
    L1:  (2)  6075932.pn.
    L2:  (2)  5696694.pn.
    L3:  (2)  5682320.pn.
    L4:  (2)  5668732.pn.
    L5:  (183) (electrical adj circuit) and (neur$4 adj net$4)
    L6:  (22) (electrical adj circuit) same (neur$4 adj net$4)
    L7:  (1) neur$4 adj net$4 adj electrical adj circuit
    L8:  (26671) neur$4 same net$4 model$1 same electrical same circuit
    L9:  (3) (neur$4 adj net$4) same (electrical adj circuit) same model$1
    L10: (0) neur$4 adj net$4 adj power adj supply
Failed
Saved
Favorites
Tagged (2)
UDC
Queue
Trash

*3/19/04*

*reviewed all*

| U. | Document ID | Issue Dat | Pages | Title | Current OR | Current XR | Retrieval | Inventor | S | C | P | 3 | Im |
|----|-------------|-----------|-------|-------|-----------|-----------|-----------|----------|---|---|---|---|----|

Ready

IEEE HOME I SEARCH IEEE I SHOP I WEB ACCOUNT I CONTACT IEEE

◈IEEE

| Membership | Publications/Services | Standards | Conferences | Careers/Jobs |

**IEEE** *Xplore*®
RELEASE 1.6

Welcome
**United States Patent and Trademark Office**

IEEE *Xplore*®
1 Million Documents
1 Million Users
...And Growing

Help   FAQ   Terms   IEEE   Quick Links   ▼

**» Search Results**

Peer Review

**Welcome to IEEE Xplore**
- ○ Home
- ○ What Can I Access?
- ○ Log-out

**Tables of Contents**
- ○ Journals & Magazines
- ○ Conference Proceedings
- ○ Standards

**Search**
- ○ By Author
- ○ Basic
- ○ Advanced

**Member Services**
- ○ Establish IEEE Web Account
- ○ Access the IEEE Member Digital Library

Your search matched **26** of **1013964** documents.
A maximum of **500** results are displayed, **15** to a page, sorted by **Relevance** in **Descending** order.

**Refine This Search:**
You may refine your search by editing the current search expression or entering a new one in the text box.

(new*<phrase> ref*) and (electrical<phrase> circuit)

| Search |

☐ Check to search within this result set

**Results Key:**
**JNL** = Journal or Magazine   **CNF** = Conference   **STD** = Standard

---

1 **Fault diagnosis in electronic circuits based on bilinear transformation in 3-D and 4-D spaces**
*Czaja, Z.; Zielonko, R.;*
Instrumentation and Measurement, IEEE Transactions on
, Volume: 52 , Issue: 1 , Feb. 2003
Pages:97 - 102

[Abstract]   [PDF Full-Text (546 KB)]   **IEEE JNL**

---

2 **Using wavelet neural networks for the optimal design of electromagnetic devices**
*Wu Qing; Shen Xueqin; Yang Qingxin; Yan Weili;*
Magnetics, IEEE Transactions on , Volume: 33 , Issue: 2 , March 1997
Pages:1928 - 1930

[Abstract]   [PDF Full-Text (328 KB)]   **IEEE JNL**

---

3 **A MOS circuit for a nonmonotonic neural network with excellent retrieval capabilities**
*Asai, T.; Yokotsuka, H.; Fukai, T.;*
Neural Networks, IEEE Transactions on , Volume: 7 , Issue: 1
, Jan. 1996
Pages:182 - 189

[Abstract]   [PDF Full-Text (712 KB)]   **IEEE JNL**

---

4 **5th Biennial IEEE Conference on Electromagnetic Field Computation (CEFC)**

Magnetics, IEEE Transactions on , Volume: 29 , Issue: 2 , Mar